## **Digital FET, N-Channel**

## FDV303N

## **General Description**

These N-Channel enhancement mode field effect transistors are produced using ON Semiconductor's proprietary, high cell density, DMOS technology. This very high density process is tailored to minimize on-state resistance at low gate drive conditions. This device is designed especially for application in battery circuits using either one lithium or three cadmium or NMH cells. It can be used as an inverter or for high-efficiency miniature discrete DC/DC conversion in compact portable electronic devices like cellular phones and pagers. This device has excellent on-state resistance even at gate drive voltages as low as 2.5 V.

#### **Features**

- 25 V, 0.68 A Continuous, 2 A Peak
  - $R_{DS(ON)} = 0.45 \Omega @ V_{GS} = 4.5 V$
  - $R_{DS(ON)} = 0.6 \Omega @ V_{GS} = 2.7 V$
- Very Low Level Gate Drive Requirements Allowing Direct Operation in 3 V Circuits, V<sub>GS(th)</sub> < 1 V</li>
- Gate-Source Zener for ESD Ruggedness, > 6 kV Human Body Model
- Compact Industry Standard SOT-23 Surface Mount Package
- This Device is Pb-Free, Halogen Free/BFR Free and is RoHS Compliant



## ON Semiconductor®

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SOT-23 (TO-236) CASE 318-08 STYLE 21

#### **MARKING DIAGRAM**



Aor blank = One/two character Loacation Code

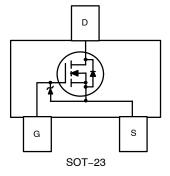
303 = Specific Device Code M = Date Code

■ = Date Code ■ = Pb-Free Package

(Note: Microdot may be in either location)

- \* Location code can be blank or with characters indicating manufacturing location
- \* Date Code orientation and overbar may vary depending upon manufacturing location.

## **PIN ASSIGNMENT**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

#### FDV303N

## **MOSFET MAXIMUM RATINGS** $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	FDV303N	Units
$V_{DSS}$	Drain-Source Voltage, Power Supply Voltage	25	V
$V_{GSS}$	Gate-Source Voltage, V <sub>IN</sub>		V
I <sub>D</sub>	Drain/Output Current - Continuous - Pulsed	0.68 2	Α
$P_{D}$	P <sub>D</sub> Maximum Power Dissipation		W
T <sub>J</sub> , T <sub>STG</sub>	T <sub>J</sub> , T <sub>STG</sub> Operating and Storage Temperature Range		°C
ESD	Electrostatic Discharge Rating MIL–STD–883D Human Body Model (100 pf / 1500 $\Omega$ )	6.0	kV

## THERMAL CHARACTERISTICS

I	Symbol	Parameter	Ratings	Units
	$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient	357	°C/W

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
FDV303N	SOT-23 Case 318-08	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

## FDV303N

## **ELECTRICAL CHARACTERISTICS** $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Conditions		Тур	Max	Units
OFF CHA	ARACTERISTICS		•			
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$				٧
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		26		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μΑ
		T <sub>J</sub> = 55°C			10	μΑ
$I_{GSS}$	Gate - Body Leakage Current	V <sub>GS</sub> = 8 V, V <sub>DS</sub> = 0 V			100	nA
ON CHA	RACTERISTICS (Note 1)					
ΔV <sub>GS(th)</sub> / ΔT <sub>J</sub>	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		-2.6		mV/°C
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	0.65	0.8	1	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.5 A		0.33	0.45	Ω
, ,		T <sub>J</sub> =125°C		0.52	0.8	1
		V <sub>GS</sub> = 2.7 V, I <sub>D</sub> = 0.2 A		0.44	0.6	
I <sub>D(ON)</sub>	On-State Drain Current	V <sub>GS</sub> = 2.7 V, V <sub>DS</sub> = 5 V				Α
9FS	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 0.5 A		1.45		S
DYNAMI	C CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		50		pF
C <sub>oss</sub>	Output Capacitance	7		28		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	7		9		pF
SWITCH	ING CHARACTERISTICS (Note 1)		•			
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DD} = 6 \text{ V}, I_D = 0.5 \text{ A}, V_{GS} = 4.5 \text{ V}, R_{GEN} = 50 \Omega$		3	6	ns
t <sub>r</sub>	Turn – On Rise Time	1		8.5	18	ns
t <sub>D(off)</sub>	Turn - Off Delay Time	1		17	30	ns
t <sub>f</sub>	Turn – Off Fall Time	1		13	25	ns
Qq	Total Gate Charge	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 0.5 A, V <sub>GS</sub> = 4.5 V		1.64	2.3	nC
Q <sub>gs</sub>	Gate-Source Charge	1		0.38		nC
Q <sub>gd</sub>	Gate-Drain Charge	†		0.45		nC
	SOURCE DIODE CHARACTERISTICS A		•	•	•	•
Is	Maximum Continuous Drain-Source Did			0.3	Α	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 0.5 A (Note 1)		0.83	1.2	V

<sup>1.</sup> Pulse Test: Pulse Width < 300  $\mu$ s, Duty Cycle < 2.0%.

#### FDV303N

## **TYPICAL CHARACTERISTICS**

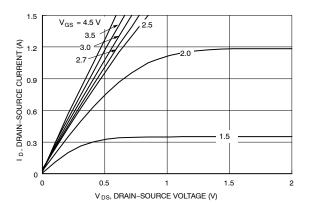


Figure 1. On-Region Characteristics

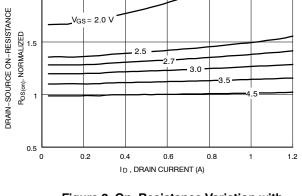


Figure 2. On–Resistance Variation with Drain Current and Gate Voltage

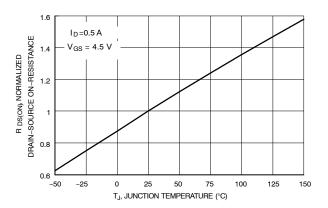


Figure 3. On–Resistance Variation with Temperature

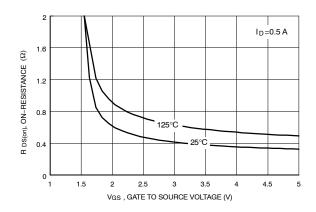


Figure 4. On Resistance Variation with Gate-To- Source Voltage

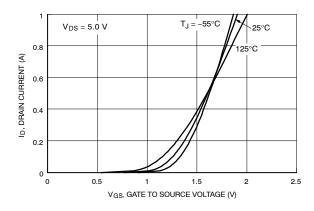


Figure 5. Transfer Characteristics

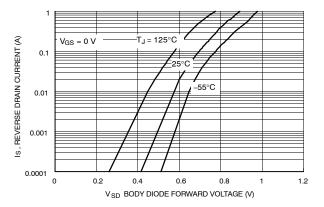


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

## **TYPICAL CHARACTERISTICS** $T_J = 25^{\circ}C$ Unless Otherwise Noted (continued)

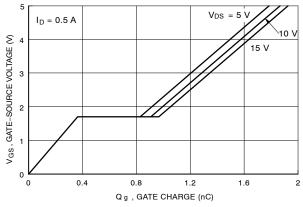


Figure 7. Gate Charge Characteristics

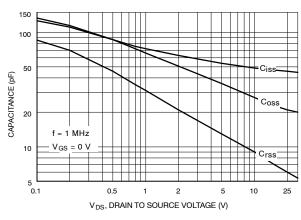


Figure 8. Capacitance Characteristics

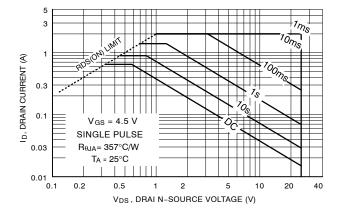


Figure 9. Maximum Safe Operating Area

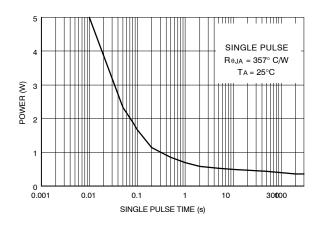


Figure 10. Single Pulse Maximum Power Dissipation

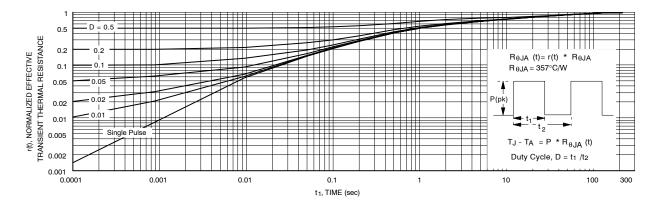


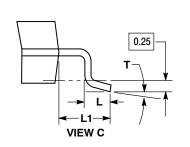
Figure 11. Transient Thermal Response Curve

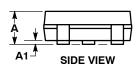


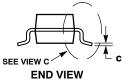
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**DATE 30 JAN 2018** 

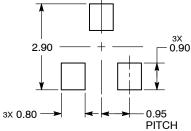
# SCALE 4:1 D - 3X b **TOP VIEW**







#### **RECOMMENDED SOLDERING FOOTPRINT**



DIMENSIONS: MILLIMETERS

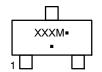
3. ANODE

#### NOTES:

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH.
  MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.89	1.00	1.11	0.035	0.039	0.044	
A1	0.01	0.06	0.10	0.000	0.002	0.004	
b	0.37	0.44	0.50	0.015	0.017	0.020	
С	0.08	0.14	0.20	0.003	0.006	0.008	
D	2.80	2.90	3.04	0.110	0.114	0.120	
E	1.20	1.30	1.40	0.047	0.051	0.055	
е	1.78	1.90	2.04	0.070	0.075	0.080	
L	0.30	0.43	0.55	0.012	0.017	0.022	
L1	0.35	0.54	0.69	0.014	0.021	0.027	
HE	2.10	2.40	2.64	0.083	0.094	0.104	
Т	O٥		10°	O۰		10°	

#### **GENERIC MARKING DIAGRAM\***



XXX = Specific Device Code

= Date Code

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

STYLE 1 THRU 5: CANCELLED	STYLE 6: PIN 1. BASE 2. EMITTER 3. COLLECTOR	STYLE 7: PIN 1. EMITTER 2. BASE 3. COLLECTOR	STYLE 8: PIN 1. ANODE 2. NO CONNECTION 3. CATHODE	ı	
STYLE 9:	STYLE 10:	STYLE 11: PIN 1. ANODE 2. CATHODE 3. CATHODE-ANODE	STYLE 12:	STYLE 13:	STYLE 14:
PIN 1. ANODE	PIN 1. DRAIN		PIN 1. CATHODE	PIN 1. SOURCE	PIN 1. CATHODE
2. ANODE	2. SOURCE		2. CATHODE	2. DRAIN	2. GATE
3. CATHODE	3. GATE		3. ANODE	3. GATE	3. ANODE
STYLE 15:	STYLE 16:	STYLE 17: PIN 1. NO CONNECTION 2. ANODE 3. CATHODE	STYLE 18:	STYLE 19:	STYLE 20:
PIN 1. GATE	PIN 1. ANODE		PIN 1. NO CONNECTION	I PIN 1. CATHODE	PIN 1. CATHODE
2. CATHODE	2. CATHODE		2. CATHODE	2. ANODE	2. ANODE
3. ANODE	3. CATHODE		3. ANODE	3. CATHODE-ANODE	3. GATE
STYLE 21:	STYLE 22:	STYLE 23:	STYLE 24:	STYLE 25:	STYLE 26:
PIN 1. GATE	PIN 1. RETURN	PIN 1. ANODE	PIN 1. GATE	PIN 1. ANODE	PIN 1. CATHODE
2. SOURCE	2. OUTPUT	2. ANODE	2. DRAIN	2. CATHODE	2. ANODE
3. DRAIN	3. INPUT	3. CATHODE	3. SOURCE	3. GATE	3. NO CONNECTION
STYLE 27: PIN 1. CATHODE 2. CATHODE	STYLE 28: PIN 1. ANODE 2. ANODE				

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